## The multimodal dependence of anodic alumina film porous nanostructure on anodizing potential

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## ABSTRACT

The dependence of the nanostructure of porous anodic alumina films (PAAFs) on anodizing potential is useful in studies of PAAF growth kinetics and mechanism and for adjusting their structural properties for numerous applications often through linear dependencies that are not sufficiently justified. Suitable Al anodizing experiments were performed. Proper equations were formulated describing in steady state the dependence on the anodic potential  $P_{\rm an}$  and the electrolysis voltage  $\Delta V$  of PAAFs' main structural features, mean cell width  $D_c$ , pore base diameter  $D_p$  and barrier layer thickness *blt*. In the widest  $P_{an}$  and  $\Delta V$  definition domains, retaining typical PAAF structure, these are implicit pseudolinear equations,  $D_c = f_c P_{an} = f_c \Delta V + g_c$ ,  $D_{\rm p} = f_{\rm p}P_{\rm an} = f_{\rm p}\Delta V + g_{\rm p}$  and  $blt = f_{\rm b}P_{\rm an} = f_{\rm b}\Delta V + g_{\rm b}$ ,  $(f_{\rm c}, f_{\rm p}, f_{\rm b} > 0), (g_{\rm c}, g_{\rm p}, g_{\rm b} < 0), \text{ where } f_{\rm c}, f_{\rm p}, f_{\rm b}, g_{\rm c}, g_{\rm p}$ and  $g_b$  generally depend on many kinetic parameters, some of which depend in turn on  $P_{an}$ ,  $\Delta V$  or other additional parameters, some of which are interdependent etc. These equations describing the dependence of  $D_{\rm c}$ ,  $D_{\rm p}$  and *blt* on  $P_{\rm an}$  and  $\Delta V$  become exact linear in anodizing regimes ensuring that all kinetic parameters defining  $f_c$ ,  $f_p$ ,  $f_b$   $g_c$ ,  $g_p$  and  $g_b$ are constant, which is rather impossible within such domains. If  $f_c$ ,  $f_p$ ,  $f_b$ ,  $g_c$ ,  $g_p$  and  $g_b$  change, the  $D_c$ ,  $D_{\rm p}$  and *blt* vs.  $P_{\rm an}$  and  $\Delta V$  plots deviate from linear by different modes, while each plot profile may differ from the rest. Experimental linear approximations refer to narrower domains, often for anodizing

regimes giving the best hexagonal order of pores. The shift of domains produces changes in gradient and intercept. Moreover the intercept may become < 0 or  $\ge 0$ . Linear or other monotonic  $D_c$ ,  $D_p$  and *blt* vs.  $P_{an}$  or  $\Delta V$  plots and exceptions are sufficiently explained for the first time. These results are important for Al anodizing electrochemistry and PAAF applications.

**KEYWORDS:** Al anodization, porous alumina films, nanostructure-potential dependence, equations.

## **1. INTRODUCTION**

During Al anodization in pore-forming electrolytes, porous anodic alumina films (PAAFs) grow [1]. In such electrolytes, e.g. oxalic, sulphuric, phosphoric, tartaric, etc. acids, PAAFs grow in three sequential stages, the first and second transient stages and the steady state one. In steady state its structure is characterised as a close-packed array of about-hexagonal columnar cells [2-5]. Each cell contains an elongated roughly cylindrical pore vertical to the Al surface which extends from the metal|oxide interface to the top surface; among this interface and pore bottom the thin compact spherical sector shell-shaped barrier-type oxide layer with thickness about 1 nm per V of applied voltage is interposed [2-5].

Due to self-organized structure and specific electrochemical behaviour, Al anodizing has become an exciting model process in solid-state electrochemistry [3, 4, 6, 7]. Also PAAFs have become a fundamental tool to develop functional

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Linear (usually) or other monotonic dependencies of the main structural features of PAAFs on electrolysis (anodizing) voltage ( $\Delta V$ ) or on anodic potential  $(P_{an})$  are reported in the literature for various electrolytes [5, 6, 22-27], which are not adequately explained yet. Linear dependency rules are generally used for tuning adjustable PAAF structural features. The main structural features are the mean cell width  $(D_c)$  correctly defined as the diameter of the circle with area identical to that of the mean cell, interpore distance  $(D_{int}, which is$ defined for hexagonally ordered porous structure as  $D_{\text{int}} = D_c/1.05$ , pore base diameter ( $D_p$ ) and barrier layer thickness (blt). The pore surface density near Al (n) and  $D_c$  obey  $n\pi(D_c^2/4) = 1$ ; thus they change oppositely. At given anodizing conditions, e.g. electrolyte type, concentration (c), temperature (T), etc., the structural features change when the current density in Al anode (j) or  $P_{an}$  or  $\Delta V$ changes. The above dependencies refer generally to the steady state stage of film growth. Results are obtained for anodizing times (t), which can extend from the beginning of steady state up to much higher times. Noticeable results of linear or nonlinear dependencies are briefly presented below.

Al anodizing in  $H_3PO_4$  electrolyte at c = 0.4 M, t = 60 min, T = 25 °C and constant  $\Delta Vs$  in the region 80–120 V, gave  $D_c \approx 2.77 \Delta V$ ,  $blt \approx 1.04 \Delta V$ and  $D_{\rm p} \approx 1.29 \Delta V$  [22]. In H<sub>2</sub>SO<sub>4</sub> at *j*s in the region 0.5-50 mA cm<sup>-2</sup>, t = 5-300 s corresponding to the initial range of steady state stage and  $\Delta V$  varying from  $\approx 2.5$  V up to almost 20 V (that is a large enough range for this electrolyte), grouped results in each case ((c = 2M, T = 10, 20, 30 and 40 °C) and (T = 20 °C, c = 0.5, 1.0, 2.0 and 4.0 M)) were found to obey  $D_c = 1.99\Delta V + 12.1$  nm [23]. In each case  $D_{\rm p}$  is almost independent of  $\Delta V$  in the region of lower  $\Delta V$ s up to some higher  $\Delta V$  value different in each case, after which it clearly increases, while blt increases monotonically with  $\Delta V$  but the related plot bends to the right [23]. With  $H_2SO_4$  20wt% electrolyte,  $\Delta V = 15-25$  V, T = 1 °C and ts ranged from 125 min at 25 V to 1,240 min at 15 V so that the obtained film thickness was 140 µm, reported data

give  $D_{int} \approx 3.2\Delta V - 12$  nm and  $D_p \approx 1.3\Delta V - 0.5$  nm [24]. Also with H<sub>2</sub>SO<sub>4</sub> 20wt%,  $\Delta V = 15-25$  V and T = -8, 1 and 10 °C,  $D_{int}$  and  $D_p$  were found to obey relatively accurately  $D_{int} = (1.84, 2.10 \text{ and } 1.87)\Delta V + (12.23, 12.20 \text{ and } 12.72) \text{ nm and } D_p = (0.80, 0.53 \text{ and } 0.72)\Delta V + (1.06, 12.35 \text{ and } 9.34) \text{ nm, respectively } [25].$ 

Collected data for several electrolytes and conditions showed usually linear dependencies of structural features on  $\Delta V$  [6], but the gradients and intercepts seem to generally depend, more or less, on the electrolyte and specific anodizing regime. For H<sub>2</sub>SO<sub>4</sub>electrolyte [5] at c = 1.53 M, j = 15 mA cm<sup>-2</sup>, T = 20, 25 and 30 °C, various ts after the start of steady state at about 2 min and up to 30, 80 and 80 min, respectively, and  $P_{ans}$  in the range 10–20 V, the mean  $D_c$  at each T in steady state was found to obey  $D_c \approx 2.1P_{an} + 12.6$  nm. At each T,  $P_{an}$  increased with t and approximate linear dependencies at these Ts gave  $D_c \approx (4.6, 7.3 \text{ and } 10.0)P_{an} - (27.7, 60.6$ and 79.6) nm, respectively, thus with much different gradients and intercepts.

In H<sub>2</sub>C<sub>2</sub>O<sub>4</sub> electrolyte at j = 10 mA cm<sup>-2</sup>, c = 0.60 M, T = 20 °C and t < 60 min in quasi-steady state  $\Delta V$ gave a plateau  $\approx 46$  V. Then  $\Delta V$  increased significantly to 54 V at 180 min and  $D_{int}$  changed as  $D_{int} = 2.81\Delta V - 1.7$  nm [26], which agrees with results in [19]. In H<sub>2</sub>C<sub>2</sub>O<sub>4</sub> a linear sweep voltammetry method was applied at c = 0.075 - 0.300 M (+ ethanol 5-10 vol. %), T = -1 to 0 °C prior to the start of anodization and up to a value below 3 °C during anodization and t = 90 min corresponding to the initial region of steady state [27]. Up to this t,  $\Delta V$ increased to 120–225 V, then remained constant. Relatively accurate linear dependences  $D_{int} = 2.4\Delta V$ - 44 nm,  $blt = 1.1\Delta V - 12$  nm were obtained, but  $D_p$ was kept almost constant around 50–60 nm.

In H<sub>2</sub>SO<sub>4</sub> electrolyte at constant *cs* in the range 0.25–1.53 M, *Ts* in the range 0–35 °C,  $\Delta V = 25$  V (best ordering voltage regime for H<sub>2</sub>SO<sub>4</sub> PAAFs [19, 28]) and *t* up to 90 min, the *j* vs. *t* plot had a highly variable profile in steady state [29]. At low *cs* and *Ts*, *j* was almost constant. But on increasing *c* and/or *T* the *j* vs. *t* plots gradually shifted upwards and left and concurrently presented high maxima due to significant change with *t* of *blt* and other related structural features, despite constant  $\Delta V$ . Also, in this electrolyte at constant *c*, *T*, *P*<sub>an</sub> and varying *t* up to 180 min, the *j*,  $\Delta V$ , *n*, *D<sub>c</sub>* and *D*<sub>int</sub> changed

significant in steady state [30, 31]. These results along with the relative stability of some structural features while  $\Delta V$  varies and deviation of the structural features vs.  $\Delta V$  plots from linear ones in various ways in certain cases [23, 27], question the general reliability of linear or other monotonic dependence rules for quantitatively tuning the structural features.

Most often the linear or other monotonic plots refer to  $\Delta V$  change. But  $\Delta V = P_{an} + \Delta V_{bs} - P_{cath}$ , where  $\Delta V_{bs}$  is potential drop in bath solution and  $P_{cath}$  is cathodic potential ( $\Delta V$ ,  $P_{an}$  and  $\Delta V_{bs} > 0$ and  $P_{cath} < 0$ ). Each  $P_{an}$ ,  $\Delta V_{bs}$  and  $P_{cath}$  depends on current (*I*). When  $\Delta V$  varies,  $P_{an}$ ,  $\Delta V_{bs}$  and  $P_{cath}$ are readjusted to satisfy this equation with common *I*. Thus *I*, *j* and mean current density in cathode ( $j_c$ ) change. There is no reason for  $D_c$ ,  $D_{int}$ ,  $D_p$  and *blt* to depend on  $\Delta V_{bs} - P_{cath}$ . These must depend only on the potential drop in the barrier layer, which is not determinable and is inevitably approached by  $P_{an}$  (vs. SHE).

For each electrolyte many different Al anodizing regimes are possible. The simplest are shown in Table 1. The actual ones are many more, as more variable anodizing parameters and various experimental methods may be applied etc. Reasonably, the dependence of PAAF structure on anodizing potential must be somehow affected by anodizing regime.

The above point out the following still-open research subjects: (i1) Explanation of the fact that gradients and intercepts of linear plots vary widely even for given electrolyte and identical or adjacent conditions. (ii<sub>1</sub>) Explanation of the fact that at given c and T and various constant js or  $\Delta V$ s or  $P_{\rm an}$ s, the gradients and intercepts may differ strongly in plots of structural features vs.  $\Delta V$  or  $P_{\rm an}$  in the initial or later range of steady state and in plots for given j and various ts [5, 26, 27]. (iii<sub>1</sub>) Rules to obtain representative results, helping to distinguish the real dependencies.  $(iv_1)$  Detection of any effect of  $\Delta V_{\rm bs}$  -  $P_{\rm cath}$  in reported dependencies, unidentified heretofore.  $(v_1)$  Explanation of exceptions from linear or other monotonic increasing change of structural features with  $P_{\rm an}$  or  $\Delta V$  in certain anodizing regimes [29-31]. (vi<sub>1</sub>) General explanation of results in each anodizing regime.

In this work, experimental results are obtained at suitable Al anodizing conditions which clearly

dispute the general validity of the linear or other monotonic increase of the structural features with  $P_{an}$  and  $\Delta V$ . Additional results for  $\Delta V_{bs}$  and  $P_{cath}$ were also obtained within large ranges of anodizing parameters *I* and *T*, to determine the dependence of  $\Delta V_{bs}$  and  $P_{cath}$  on *I*. Equations are formulated describing the actual dependence of PAAF structural features on  $P_{an}$  and  $\Delta V$  and requirements are derived for linear dependencies. Predictions of equations are verified with present and previous literature results. Replies are given to open research subject queries. Lastly, an effective theory applicable to the study of PAAF growth kinetics and mechanism is developed.

### 2. MATERIALS AND METHODS

For thorough studies of the kinetics and mechanism of PAAF growth, thermostatically controlled three-electrode cell setup is necessary [29, 30, 32]. The setup used here is similar to that in [30, 31], consisting of upright Al working electrode and counter cathodic electrode (two Pb sheets symmetrically placed on either side of Al at distance 5 cm) and Hg/Hg<sub>2</sub>SO<sub>4</sub> reference electrode. Al specimens with thickness 0.5 mm, purity  $\geq$  99.95% (Merck pro-analysis), dimensions of anodised surface  $3 \times 3$  cm<sup>2</sup> and entire anodized surface area  $(S_{g})$  18.55 cm<sup>2</sup> [30] were used. The Pb cathodes (purity  $\geq$  99.968%, Merck pro-analysis) had thickness 0.5 mm, dimensions of conductive surface  $5.5 \times 5.5$  cm<sup>2</sup> and total conductive surface (S<sub>c</sub>) 122.05 cm<sup>2</sup>. Al anodizing was performed in rigorously stirred H<sub>2</sub>SO<sub>4</sub> electrolyte which is the most commonly used one.

A homemade power supply (Potentiostat – Automatic Reference Control – Model: PA–495) was used with upper limits of power output  $\approx 50$  W, current 2 A and voltage 32.5 V. Al was anodized at conditions c = 5% w/v (0.51 M), T = 25 (±0.1–0.2) °C,  $P_{an} = 23.615$  V and  $ts \le 120$  min with  $\Delta V$  variable around 25 V, which defines the voltage regime that gives the best order of pores [19, 28], (case (v) in Table 1). Structural features of PAAFs were determined by field emission scanning electron microscopy (FESEM) (JEOL JSM -7401f). After selective removal of the oxide by chromophosphoric acid solution [3], the *n*s were found by counting the imprints of the cell/pore units in precisely determined Al surface areas. From *n*s, the

Table 1. Experimental conditions in the simplest applicable Al anodizing regimes for a given electrolyte. The
anodizing parameters written in upright letters are the imposed ones and the parameters written in light italic
letters are the ones produced during the experiments. The abbreviations p.s.s. and i.s.s.r. mean prolonged
steady state and initial steady state range, respectively.

Aluminium anodizing regime	Electrolyte concentration c	Temperature T	Current density j	Time t	Anodic potential P <sub>an</sub>	Anodizing voltage $\Delta V$
(i)	constant	constant	constant	variable (p.s.s.)	variable	variable
(ii)	constant	variable	constant	variable (i.s.s.r.)	variable	variable
(iii)	variable	constant	constant	variable (i.s.s.r.)	variable	variable
(iv)	constant	constant	variable	variable (i.s.s.r.)	variable	variable
(v)	constant	constant	variable	variable (p.s.s.)	constant	variable
(vi)	constant	variable	variable	variable (i.s.s.r.)	constant	variable
(vii)	variable	constant	variable	variable (i.s.s.r.)	constant	variable
(viii)	constant	constant	variable	variable (i.s.s.r.)	variable	variable
(ix)	constant	constant	variable	variable (p.s.s.)	variable	constant
(x)	constant	variable	variable	variable (i.s.s.r.)	variable	constant
(xi)	variable	constant	variable	variable (i.s.s.r.)	variable	constant
(xii)	constant	constant	variable	variable (i.s.s.r.)	variable	variable

 $D_{cs}$  were then found. Other structure details were determined in films' fracture surfaces formed by bending Al specimens carrying the films.

Independent Al anodizing experiments were also conducted to study the cathodic potential and potential drop in bath bulk solution in wide ranges of *I*s and *T*s, irrespective of the detailed phenomena taking place in Al anode. The release of H<sub>2</sub> in cathode should also be examined, for which galvanostatic experiments serve better. Constant *I*s varying from 10 mA up to 2 A were applied. At each *T* the final maximum *I* was that at which one of the above limits of voltage or power output was reached first. The *j*, *j*<sub>c</sub>, *I*, *S*<sub>g</sub> and *S*<sub>c</sub> are related by  $j_c = I/S_c = jS_g/S_c = 0.152j$ . At I = 10 mA, j = 0.55mA cm<sup>-2</sup> and  $j_c = 0.082$  mA cm<sup>-2</sup> and at I = 2 A, j = 107.82 mA cm<sup>-2</sup> and  $j_c = 16.39$  mA cm<sup>-2</sup>. *I*s < 10 mA were not employed as the corresponding *j*s are very low, unsuitable for Al anodizing science and technology and PAAF applications.

The cathodic potential in Pb was measured with the pin mouth hole of reference electrode close to the Pb cathode,  $P_{\text{cath}} - P_{\text{ref}}$  (reference electrode close to cathode) =  $P_{\text{cath}} - P_{\text{ref}}(c)$ . By definition  $P_{\text{cath}} < 0$ and because  $P_{\text{ref}} > 0$  (see below)  $P_{\text{cath}} - P_{\text{ref}}(c) < 0$ always and at given conditions  $P_{\text{cath}} - P_{\text{ref}}(c) + P_{\text{ref}} = P_{\text{cath}}(\text{vs. SHE}(c)) = P_{\text{cath}}$  which is the real cathodic potential.  $P_{\text{cath}} - P_{\text{ref}}$  was also measured with the pin mouth hole of reference electrode close to the anode,  $P_{\text{cath}} - P_{\text{ref}}$  (reference electrode close to the anode) =  $P_{\text{cath}} - P_{\text{ref}}(a)$ . It was < 0 but >  $P_{\text{cath}} - P_{\text{ref}}(c)$ . The potential drop in solution from the anode to the cathodes ( $\Delta V_{\text{bs}}$ ) is thus  $\Delta V_{\text{bs}} = [P_{\text{cath}} - P_{\text{ref}}(c)] - [P_{\text{cath}} - P_{\text{ref}}(a)] > 0$ . Then  $\Delta V = [P_{\text{an}} - P_{\text{ref}}(a)] + \Delta V_{\text{bs}} + [P_{\text{ref}}(c) - P_{\text{cath}}] = P_{\text{an}} + \Delta V_{\text{bs}} - P_{\text{cath}} > 0$ , where  $P_{\text{an}} - P_{\text{ref}}(a)$  is the anodic potential vs. reference electrode attached close to Al anode.

Possible changes of  $P_{\text{cath}} - P_{\text{ref}}(c)$  and  $P_{\text{cath}} - P_{\text{ref}}(a)$ along the conductive Pb and anodized Al surfaces were studied. In each horizontal level crossing Pb,  $-P_{\text{cath}} + P_{\text{ref}}(c) > 0$  was independent of reference electrode attachment position around Pb. The  $-P_{\text{cath}} + P_{\text{ref}}(c)$  value decreased slightly along the vertical surface of Pb cathode and upwards by e.g.  $\approx 10 \text{ mV}$ at I = 900 mA and T = 25 °C. Thus,  $-P_{\text{cath}} + P_{\text{ref}}(c)$ remains practically constant along the Pb surface. In each horizontal level crossing the anodised Al surface, the  $-P_{\text{cath}} + P_{\text{ref}}(a) > 0$  value was also independent of reference electrode attachment position around the Al surface. But  $-P_{\text{cath}} + P_{\text{ref}}(a)$  increased perceptibly and almost linearly upwards by several tens of mV at this I and T. Then, measurements at the middle of the narrow vertical side surface of Pb cathodes and Al anode were taken as tolerably representative.  $P_{\text{caths}}$  and  $\Delta V_{\text{bs}}$ s, determined at various *Is* (or  $j_{\text{cs}}$ ) and T = 5, 15, 25 and 35 °C, and  $P_{\text{ref}}$  (vs. SHE) values at these *Ts* 0.631, 0.623, 0.615 and 0.607 V [33] are used in the following analysis.

## **3. RESULTS AND DISCUSSION**

# 3.1. All anodizing at constant c, T and $P_{an}$ and variable t. Results disputing the monotonic increase of structural features with $P_{an}$ and $\Delta V$ . Important details of PAAF structure

In Fig. 1a-d the change of j,  $\Delta V$ , n and  $D_c$  with t is shown at c = 0.51 M, T = 25 °C,  $P_{an} = 23.615$  V and  $ts \leq 120$  min. The inset is a magnification of jvs. t plot at the very early stages of anodizing. The j abruptly rises, AB, then drops fast in the first transient stage BC. In BC a microscopically flat barrier type layer of oxide is formed; around point C, pores are nucleated on the oxide surface and the PAAF structure is generated [34-38]. In the second transient stage CD j rises, pores are developed and organized producing the PAAF structure [15-20, 36-41], completed around D [6, 22]. DE is the steady state that extends to higher ts DEFGHIJ where PAAF structure near the Al surface is reproduced and may remain (almost) stable or change.

In Fig. 1c FESEM micrographs of structural details at corresponding or indicated *ts* appear: imprints of cell/pore units on the Al surface (metal|oxide interface) at points D, G, H, I and J revealing their order; spherical sector-shaped ends to the Al side of columnar cells at H; section of cell/pore units around pore bases disclosing spherical sector shellshaped barrier layer at G; section of pores and pore walls at distance from Al  $\approx$  23 µm (middle of film thickness) at H; section of pore walls and pores at distance from Al  $\approx$  92 µm (middle of thickness) showing termination and generation of pores.

The *j* rises in stage CD, then in stage DEFGHIJ a plateau DEFG with an imperceptible shallow minimum around F appears, followed by high peak around H.  $\Delta V$  always lies around 25 V and generally follows *j*. In CD stage,  $D_c$  and  $\Delta V$  rise and *n* drops while *j* rises. In DEFGHIJ stage, *n* and  $\Delta V$  vary similarly and  $D_c$  inversely to *j*. Shallow *j* minimum at F implies that imperceptible *n* and  $\Delta V$  minima and  $D_c$  maximum are expected, but

practically, these remain constant in the plateau. The order of pores strongly improves in CD stage [31]. In DEFGHIJ stage, it is almost constant in DEFG region, worsens in the GH and improves from H to the end but remains inferior to DEFG. Changes in both structural features and pore ordering are related to continuous pore termination/generation processes at both stages [31] and additional inherent thinning of the mean barrier layer occurring exclusively at the second transient stage [22]. The much thinner pore walls at about the middle of the cross section of film at J than at H are mainly due to the much longer duration of chemical pore wall attack by the electrolyte.

Despite constant  $P_{\rm an}$ ,  $D_{\rm c}$  and *n* vary in steady state. If linear or other monotonic increase of  $D_{\rm c}$  and  $D_{\rm int}$  with  $P_{\rm an}$  or  $\Delta V$  were valid, these should remain constant considering  $P_{\rm an}$  or change similarly to  $\Delta V$ , which is not the case.

Cross sections of barrier layer units formed by bending are rare in  $H_2SO_4$  films [31]. Films crack through intercellular boundaries. Micrograph e.g. at *j* peak apex shows that cells are detached rather than fractured through planes containing pore axes. The spherical sector-shell barrier layer at G is compatible with the downer ends of detached cells shown at H.

Fig. 2 shows a schematic of the cell/pore unit around pore base. The  $D_{\rm c}, D_{\rm p}, blt$  and angle ( $\varphi$ ) between pore axis and pore wall/barrier layer boundary are shown. Theoretically  $\varphi$  can change from 90° up to values well exceeding 90°. If  $\varphi = 90^\circ$ ,  $blt = 2^{-1}(D_c)$ -  $D_{\rm p}$ ), and the barrier layer is hemispherical. In general  $blt = 2^{-1}(D_c - D_p)/\sin\varphi$  ( $\varphi \ge 90^\circ$ ), increasing with  $\varphi$ . In certain electrolyte(s) and anodizing conditions the actual shape of spherical sector shell-shaped barrier layer may be imperceptibly elliptic. For e.g. H<sub>3</sub>PO<sub>4</sub> films, in the steady state growth of PAAF the thickness of barrier laver may be up to 5% higher in barrier layer/pore wall boundary than along pore axis as inferred from micrographs [22, 42], or  $\approx 2.3\%$  as predicted by steady state PAAF growth modelling [43, 44]. But its effect on PAAF growth modelling is truly negligible [45].  $\varphi \approx 136^{\circ}$  [22, 43] and  $\approx 127^{\circ}$  [44, 45] were adopted with mean  $\varphi = 131.5^{\circ}$ . Micrograph at G, Fig. 1c, predicts  $\varphi$  comparable to those values despite different electrolyte and conditions. Thus, change of  $\varphi$  with them, if any, is rather slight. For



**Fig. 1.** Plots of (a) current density, *j*, (b) corresponding anodizing voltage,  $\Delta V$ , (c) pore surface density near Al surface, *n*, and (d) mean cell width,  $D_c$ , vs. time, *t*, for Al anodizing at  $P_{an}$  (vs. SHE) = 23.615 V,  $c(H_2SO_4) = 0.51$  M and T = 25 °C. The inset in (a) is a magnification of *j* vs. *t* plot at the very early stages of anodizing. In (c) the inset FESEM micrographs at corresponding (or indicated) *t*'s show PAAF structure details that are imprints of cell/pore units on the Al surface after the selective removal of oxide and fracture surfaces.

each anodizing electrolyte it can be considered to be about constant.

From the above and earlier results [5, 29-32] it seems that at constant e.g. *j* or  $\Delta V$  or  $P_{an}$ , the  $\Delta V$ and  $P_{an}$  or *j* and  $P_{an}$  or *j* and  $\Delta V$  and other kinetic parameters and structural features of PAAF generally change slightly or significantly in steady state. Thus, it is actually a quasi-steady state. In the following, when referring to steady state, it is understood that the state is quasi-steady.



**Fig. 2.** Schematic cross section of a cell/pore unit of PAAFs around the pore base region. The pore, pore wall, barrier layer and its thickness, *blt*, angle of pore axis with the boundary of pore wall/barrier layer,  $\varphi$ , the cell width,  $D_c$ , and pore base diameter,  $D_p$ , are shown.

## **3.2. Dependencies of** $P_{\text{cath}}$ on $j_{\text{c}}$ and T and of $\Delta V_{\text{bs}}$ on I and T

 $-P_{\text{cath}}$  vs.  $j_{c}$  plots at various Ts appear in Fig. 3a which are sigmoid.  $P_{\text{cath}}$ s at given  $j_{c}$ s are generally comparable to those in the literature [46-48].  $-P_{\text{cath}}$ vs. lnj<sub>c</sub> plots, Fig. 3b, are also sigmoid curves, typical for  $H_2$  overpotential in Pb, Pt and other metals [46] which show two Tafel regions. Insets in Figs. 3a and b are magnifications of  $-P_{\text{cath}}$  vs.  $j_c$  and  $-P_{\text{cath}}$  vs. ln  $j_c$  plots in the range of lower employed  $j_c$ s which are curved. The successive regions of about-linear plots  $-P_{\text{cath}}$  vs.  $j_c$  and  $-P_{\text{cath}}$  vs.  $\ln j_c$  (Tafel region) at low enough  $j_c$ s [46] must appear in this case at  $j_c$ s < 0.082 mA cm<sup>-2</sup>. In the region of higher employed  $j_{cs}$  the Tafel equation  $-P_{cath} = a + b \ln j$ satisfactorily applies, Fig. 3b. The values of a and b at different Ts are given in Table 2. The a shows a trend to drop and b shows a trend to rise on average with T, which agree with those for various other metals such as Hg, W etc. [46]. For  $j_c$ s including the values employed here, the overpotential of H<sub>2</sub> on Pb (and other metals such as Pt) and thus both a and b are almost independent of pH, thus also almost independent of c [46]. The rate determining step of  $H_2$  release on Pb is thus electrochemical (not

diffusion-limited) and the examination here of the overpotential dependence on c is unnecessary.

 $\Delta V_{\rm bs}$  vs. I plots at various Ts appear in Fig. 3c. At each T,  $\Delta V_{\rm bs} = IR_{\rm bs}$  satisfactorily applies where  $R_{\rm bs}$ (almost independent of I) is the total Ohmic resistance of the bath bulk solution during anodizing. This expected linear dependence in turn validates the method applied to find  $\Delta V_{\rm bs}$ s.  $R_{\rm bs}$  thus found on average decreases slightly with T. This agrees with the relatively slight increase in conductivity of  $H_2SO_4$ at the employed c and Ts in the range 5–35 °C [33]. The not-strictly linear  $\Delta V_{\rm bs}$  vs. I plots and nonstrict monotonic variation of  $R_{\rm bs}$  with T are due to coexistence of two phases in bath solution during anodizing, the conductive liquid H<sub>2</sub>SO<sub>4</sub> solution and the non-conductive gaseous H<sub>2</sub> dispersed as gas bubbles in it. The amount of dispersed H<sub>2</sub> depends on I and T affecting  $R_{bs}$ . H<sub>2</sub> is accumulated more upwards due to buoyancy. Thus the conductivity of bath solution decreases (or the resistivity increases) along the vertical direction and upwards. It explains the perceptible rise of  $[-P_{cath}]$  $+ P_{ref}(a) = \Delta V_{bs} + [-P_{cath} + P_{ref}(c)] > 0$  upwards along the Al surface and the slight fall of  $-P_{\text{cath}}$  +  $P_{ref}(c) > 0$  upwards along the Pb surface. To a good approximation in Tafel region,  $P_{\rm an} = \Delta V - (\Delta V_{\rm bs} P_{\text{cath}}$ ) =  $\Delta V - (IR_{\text{bs}} + a + b \ln j_{\text{c}})$  or  $\Delta V - P_{\text{an}} = \Delta V_{\text{bs}}$  - $P_{\text{cath}} = IR_{\text{bs}} + a + b \ln j_{\text{c}}.$ 

Although  $\Delta V_{\rm bs} < -P_{\rm cath}$ ,  $\Delta V_{\rm bs}$  is not negligible compared with  $-P_{\rm cath}$ .  $\Delta V_{\rm bs} - P_{\rm cath} = 0.37, 0.37, 0.38$ and 0.38 V at the lowest and 1.42, 1.38, 1.62 and 1.58 V at the highest reached  $j_{\rm c}$ s at T = 5, 15, 25and 35 °C, respectively.  $\Delta V$  values are 18.30, 9.00, 4.40 and 2.90 V at the lowest and 31.70, 32.30, 31.00 and 25.61 V at the highest  $j_{\rm c}$ s at these *T*s. Corresponding  $P_{\rm an}$ s are 17.93, 8.63, 4.02 and 2.52 V at the lowest and 30.28, 30.92, 29.38 and 24.03 V at the highest  $j_{\rm c}$ s, thus  $\Delta V_{\rm bs} - P_{\rm cath}$  is 2.1, 4.3, 9.5 and 15.1% of  $P_{\rm an}$  at the lowest and 4.5, 4.3, 5.2 and 6.5% of  $P_{\rm an}$  at the highest  $j_{\rm c}$ s. Though  $P_{\rm an} \gg$  $\Delta V_{\rm bs} - P_{\rm cath}, \Delta V_{\rm bs} - P_{\rm cath}$  is not negligible compared to  $P_{\rm an}$ , mainly at high *T*s and low  $j_{\rm c}$ s, thus not ignorable.

The ionic conductor in bath solution has constant length, about double the distance of Al from each Pb electrode, through which I/2 current passes. For the given  $S_g$  and constant  $P_{an}$  or  $I = jS_g = j_cS_c$ , as  $S_c$  falls the mean section surface of conductor falls. Then  $j_c$  rises,  $\Delta V_{bs}$  and  $-P_{cath}$  also rise and  $(\Delta V_{bs} - P_{cath})/P_{an}$  becomes significant. At a given  $\Delta V$ ,  $S_c$ 



**Fig. 3.** Plots of the absolute cathodic potential,  $-P_{\text{cath}}$ , vs. current density in Pb cathodes,  $j_c$ , (**a**), of  $-P_{\text{cath}}$  vs. ln  $(j_c/\text{mA cm}^{-2})$  (**b**) and of the potential drop in bath bulk solution,  $\Delta V_{\text{bs}}$ , vs. current, I, (**c**).

thus defines to a significant extent the real  $P_{an}$ . The relationship  $-P_{cath} >> \Delta V_{bs}$ , Fig. 3, may change in electrochemical cell setup with large distance between Al and cathode(s), low *cs* and/or *Ts*, less conductive electrolyte, etc. The fact that  $\Delta V_{bs} - P_{cath}$  may be a significant portion of  $P_{an}$  is important when examining the dependence of PAAF structural features on  $\Delta V$ .

## **3.3.** Formulation of $D_c$ , $D_p$ and *blt* vs. $P_{an}$ and $\Delta V$ equations

During the growth of PAAF at not excessively high *j*s (thus release of  $O_2$  gas in Al anode is avoided) the consumed Al closely obeys Faraday's law [29, 32]. Then the entire current through the barrier layer is almost totally ionic and the electronic current is negligible. It is accepted that only  $O^2$ -and Al<sup>3+</sup> migrate

**Table 2.** Parameters *a* and *b* of Tafel equation  $(-P_{cath} = a + blnj)$  for hydrogen release in Pb cathodes, corresponding correlation coefficient, CORR<sub>1</sub>, resistance of bath bulk solution,  $R_{bs}$ , found from  $\Delta V_{bs}$  vs. *I* plots and corresponding correlation coefficient, CORR<sub>2</sub>, during galvanostatic Al anodizing experiments.

T/°C	a / V	<i>b /</i> V	CORR <sub>1</sub>	$10^{-1}R_{\rm bs}$ / Ohm	CORR <sub>2</sub>
5	1.010	0.117	0.991	2.73	0.987
15	0.809	0.158	0.999	2.66	0.994
25	0.894	0.123	0.995	2.15	0.987
35	0.760	0.157	0.998	2.16	0.998

in the barrier layer. Thus, the contribution to charge transport of the small amount of contaminant ionic species embodied in this layer is ignored, without injuring the ensuing analysis. For this analysis, the electrochemical kinetic equations describing the dependence of j and transport numbers of  $O^{2-}$ 

 $(tn_{an})$  and Al<sup>3+</sup>  $(tn_{ca})$   $(tn_{ca} + tn_{an} = 1)$  on the mean field strength across the barrier layer  $(E_{bl})$  and the real anodizing temperature around the barrier layer  $(T_{an})$  that exceeds *T* even slightly [29] are also necessary. In view of the above admissions these equations become

$$j = jtn_{an} + jtn_{ca} = A_2 \exp[(W_2' + n_2 a_2 F E_{bl})/(RT_{an})] + A_3 \exp[(W_3' + n_3 a_3 F E_{bl})/(RT_{an})])$$
(1)

$$tn_{an} = jtn_{an} / (jtn_{an} + jtn_{ba}) = 1/\{1 + (A_3 / A_2) \exp[(W_3' + W_2' + (n_3a_3 - n_2a_2)FE_{bl})/(RT_{an})]\}$$
(2)

where  $A_2$  and  $A_3$  are pre-exponential factors of ionic O<sup>2-</sup> and Al<sup>3+</sup> currents defined by the product of physical constants and elementary parameters of statistical physical/thermodynamic and kinetic nature [29, 49],  $W_2$ ' and  $W_3$ ' are the apparent activation energies of O<sup>2-</sup> and Al<sup>3+</sup> migrations,  $n_2$ and  $n_3$  are the O<sup>2-</sup> and Al<sup>3+</sup> valences,  $a_2$  and  $a_3$  are the activation (half-jump) distances of O<sup>2-</sup> and Al<sup>3+</sup> transport, F is Faraday's constant and R is gas constant. For  $E_{bl}$  around 1 V nm<sup>-1</sup>,  $-W_2' + n_2a_2FE_{bl} > 0$ and  $-W_3' + n_3\alpha_3FE_{bl} < 0$  [49]. Since  $W_2' < W_3'$  [49], the rate controlling step is Al<sup>3+</sup> transport. The  $a_2$ and  $a_3$  are comparable to O<sup>2-</sup> and Al<sup>3+</sup> radii 0.126 nm and 0.0535 nm [49], thus  $n_3a_3 - n_2a_2 = 3a_3 - 2a_2 < 0$ . Hence,  $-W_3' + W_2' + (n_2\alpha_2 FE_{bl} - n_3\alpha_3)FE_{bl} < 0$ . Considering constant  $A_2$ ,  $A_3$ ,  $W_2'$  and  $W_3'$ , then  $tn_{an}$ ,  $tn_{ca}$  and j are defined solely by  $E_{bl}$  and  $T_{an}$ .

Consistent with Eq. (1), *j* is very sensitive to  $E_{\rm bl}$  changes. A small rise in  $E_{\rm bl}$  produces large increase in *j*. The *j* is less sensitive to  $T_{\rm an}$  changes and presents a shallow minimum at some  $T_{\rm an}$  [32]. For example, at anodizing conditions in [32] change of  $E_{\rm bl}$  by only ±0.733% around 1 V nm<sup>-1</sup> affects *j* by ≈ ±6.6%. The required decrease in  $T_{\rm an}$  in the left side and increase in  $T_{\rm an}$  in the right side of this minimum

for *j* increase  $\approx 6.6\%$  is  $\approx 7.6\%$ . Eq. (2) predicts that  $tn_{an}$  ( $0 < tn_{an} < 1$ ) rises with  $E_{bl}$  but its rise is moderate, not as large as that of *j*. The  $tn_{an}$  also falls moderately with  $T_{an}$  e.g. for usual *T*s in the range 0–40 °C. Predictions agree with results [49, 50].

There is not a simple equation describing  $-P_{\text{cath}}$  in the whole range of  $j_c$ s employed. The *j*s corresponding to the low  $j_c$ s up to near the start of Tafel region in Fig. 3b are generally low enough, not often used for Al anodizing and applications of PAAFs. Oppositely, the *j*s corresponding to Tafel region of  $j_c$ s are those often used. To facilitate the ensuing analysis, the Tafel region of  $j_c$ s is considered. Thus at each *T*,  $-P_{\text{cath}} = a + b \ln j_c$ . From solution conductivity [33] and the expected PAAF thicknesses and mean porosities at various *t*s [30], the potential drop along the pores is found negligible compared with  $P_{\text{an}}$  [32]. There is no way to determine the exact potential drop across the barrier layer ( $\Delta P$ ), thus  $\Delta P$  is inevitably approached by  $P_{\text{an}}$  ( $\Delta P \approx P_{\text{an}}$ ).

For spherical sector shell-shaped barrier layer, ignoring other effects on  $E_{bl}$ , such as exact geometry details and dielectric behaviour of barrier layer, contaminant species embodied in this layer etc. [30],

$$E_{\rm bl} = \Delta P / blt = \sin\varphi \Delta P / [2^{-1} (D_{\rm c} - D_{\rm p})] \approx P_{\rm an} / blt = \sin\varphi P_{\rm an} / [2^{-1} (D_{\rm c} - D_{\rm p})]$$
(3)

Since 
$$P_{an} = \Delta V - (IR_{bs} + a + b \ln j_c)$$

$$2^{-1}(D_{c} - D_{p}) = \sin\varphi E_{bl}^{-1} \Delta P \approx \sin\varphi E_{bl}^{-1} P_{ap} = \sin\varphi E_{bl}^{-1} \Delta V - \sin\varphi E_{bl}^{-1} (IR_{bs} + a + b \ln j_{c})$$
(4)

or 
$$2^{-1}(D_c - D_p) = \alpha P_{ap} = \alpha \Delta V - \beta$$
 (5)

where  $\alpha = \sin\varphi E_{bl}^{-1}$  and  $\beta = \alpha (IR_{bs} + a + b\ln j_c) = \sin\varphi E_{bl}^{-1} (IR_{bs} + a + b\ln j_c)$ , both > 0. Earlier [30, 31] it was also shown that

$$tn_{\rm an} = 1 - (D_{\rm p}/D_{\rm c})^2$$
 (6)

thus  $tn_{ca} = (D_p/D_c)^2$ , which coincides with film porosity around pore bases [51]. Eq. (6) is transformed to

$$2^{-1}(D_{\rm c} - D_{\rm p}) = 2^{-1}[1 - (1 - tn_{\rm an})^{1/2}]D_{\rm c}$$
(7)  
or  $1.05D_{\rm int} = D_{\rm c} = 2^{-1}(D_{\rm c} - D_{\rm p})2[1 - (1 - tn_{\rm an})^{1/2}]^{-1}$ 

$$D_{\rm p} = 2^{\cdot 1} (D_{\rm c} - D_{\rm p}) 2 [1 - (1 - t m_{\rm an})^{1/2}]^{\cdot 1} (1 - t m_{\rm an})^{1/2} = D_{\rm c} (1 - t m_{\rm an})^{1/2}$$
(8)

For usual values of  $tn_{an} = 0.5-0.95$  [49, 50], the factors  $(1 - tn_{an})^{1/2}$ ,  $2^{-1}[1 - (1 - tn_{an})^{1/2}]$ ,  $2[1 - (1 - tn_{an})^{1/2}]^{-1}$  and  $2[1 - (1 - tn_{an})^{1/2}]^{-1}(1 - tn_{an})^{1/2}$  vary monotonically as 1.41–4.47, 0.71–2.24, 6.83–2.58

and 4.83–0.58, respectively. Eqs. (6)–(8) predict monotonic (may be linear) increase in always  $D_c$ and *blt* and usually  $D_{\rm p}$  with  $P_{\rm an}$  or  $\Delta V$ . Considering e.g. constant c and T, as  $P_{an}$  or  $\Delta V$  increases, in the first range of steady state n falls,  $D_c$  and j increase [24, 25, 27, 30] and  $tn_{an}$  does alike.  $2^{-1}(D_c - D_p)$ increases, Eq. (7), and, considering almost constant  $\varphi$ , *blt* also increases. Though  $D_c$  increases,  $(1 - tn_{an})^{1/2}$ decreases. Then, Eq. (8) shows that  $D_p$  can increase or remain almost constant (as often occurs [5, 6, 22-25, 27]), while a slight decrease cannot be excluded in some cases. Exceptions observed at constant c, T and  $P_{an}$ , Fig. 1, are also predicted by these equations. For almost constant  $T_{an}$ , when j and thus  $tn_{an}$  increases,  $E_{bl}$  increases, thus *blt* and 2<sup>-1</sup>  $(D_{\rm c} - D_{\rm p})$  decrease, Eqs. (1)–(3). Then both  $D_{\rm c}$  and  $D_{\rm p}$  decrease, Eqs. (7) and (8). Combination of Eqs. (3), (5), (7) and (8) gives

$$D_{c} = \alpha 2 [1 - (1 - tn_{an})^{1/2}]^{-1} P_{an} = f_{c} P_{an} = \alpha 2 [1 - (1 - tn_{an})^{1/2}]^{-1} \Delta V - \beta 2 [1 - (1 - tn_{an})^{1/2}]^{-1} = f_{c} \Delta V + g_{c}$$
(9)

$$D_{\rm p} = \alpha 2 [1 - (1 - t m_{\rm an})^{1/2}]^{-1} (1 - t m_{\rm an})^{1/2} P_{\rm an} = f_{\rm p} P_{\rm an} = \alpha 2 [1 - (1 - t m_{\rm an})^{1/2}]^{-1} (1 - t m_{\rm an})^{1/2} \Delta V$$

$$-\beta 2 [1 - (1 - t m_{\rm an})^{1/2}]^{-1} (1 - t m_{\rm an})^{1/2} = f_{\rm p} \Delta V + g_{\rm p}.$$
(10)

$$blt = (\sin\varphi)^{-1} 2^{-1} (D_{c} - D_{p}) = (\sin\varphi)^{-1} \alpha P_{ap} = f_{b} P_{ap} = (\sin\varphi)^{-1} \alpha \Delta V - (\sin\varphi)^{-1} \beta = f_{b} \Delta V + g_{b}$$
(11)

The pre-potential factors  $f_c$ ,  $f_p$  and  $f_b$  (> 0) are  $f_c = \sin\varphi E_{bl}^{-1} 2[1 - (1 - tn_{an})^{1/2}]^{-1}$ ,  $f_p = \sin\varphi E_{bl}^{-1} 2[1 - (1 - tn_{an})^{1/2}]^{-1}(1 - tn_{an})^{1/2}]^{-1}$ ,  $f_p = \sin\varphi E_{bl}^{-1}$ . The terms  $g_c$ ,  $g_p$  and  $g_b$  (< 0) are  $g_c = -\beta 2[1 - (1 - tn_{an})^{1/2}]^{-1}$ ,  $g_p = -\beta 2[1 - (1 - tn_{an})^{1/2}]^{-1}(1 - tn_{an})^{1/2}]^{-1}$ ,  $g_p = -\beta 2[1 - (1 - tn_{an})^{1/2}]^{-1}(1 - tn_{an})^{1/2}$  and  $g_b = -\beta(\sin\varphi)^{-1}$ . Since  $D_{int} = D_c/1.05$ ,  $D_{in}$  follows  $D_c$ . Because  $n\pi(D_c^2/4) = 1$ , by replacing  $D_c$  with  $[4/(n\pi)]^{1/2}$  in Eq. (9), equations relating n with  $P_{an}$  and  $\Delta V$  are also formulated.  $\Delta V_{bs} - P_{cath} = IR_{bs} + a + b \ln j_c$  is embodied in  $g_c$ ,  $g_p$  and  $g_b$ . Its role in related results is thus clarified. The  $f_c$ ,  $f_p$  and  $f_b$  depend on the kinetic parameters  $E_{bl}$ ,  $\varphi$  and  $T_{an}$ , also on I,  $R_{bs}$ ,  $j_c$ , a and b. At least  $T_{an}$  depends on  $P_{an}$  and j as a result of heat production mainly around pore bases and its transfer to bath bulk solution *via* solid oxide and

pore-filling solution [32], while *j* in turn depends on  $P_{an}$  via  $E_{bl} \approx \sin\varphi P_{an}/[2^{-1}(D_c - D_p)]$  and Eq. (1). As  $\Delta V$  changes the  $P_{an}$ ,  $\Delta V_{bs}$  and  $P_{cath}$  depending on the common *I* are readjusted to satisfy  $\Delta V = P_{an} + \Delta V_{bs} - P_{cath}$ , thus at least *I* and  $j_c$  depend on  $\Delta V$ . Other kinetic parameters defining  $f_c$ ,  $f_p$ ,  $f_b$ ,  $g_c$ ,  $g_p$  and  $g_b$  can also interdepend.

Hence, as  $P_{an}$  and  $\Delta V$  change, at least some of  $f_c$ ,  $f_p$ ,  $f_b$ ,  $g_c$ ,  $g_p$  and  $g_b$  depending indirectly on  $P_{an}$  and  $\Delta V$  change too. Eqs. (9)–(11) are thus implicit and pseudo-linear. In the widest possible definition domains of  $P_{an}$  and  $\Delta V$ , within which the characteristic cellular columnar porous structure is retained, strict linear dependencies of  $D_c$ ,  $D_p$  and *blt* on  $P_{an}$  and  $\Delta V$  may occur if all the above kinetic parameters remain constant. Such anodizing regime(s) seem impossible

or at most limited. These definition domains of  $P_{an}$ and  $\Delta V$  are usually unknown or not examined. The equation  $\Delta V_{bs}$  -  $P_{cath} = IR_{bs} + a + b \ln j_c$ , embodied in Eqs. (9)–(11), is also a tolerable approximation and not a strict, as expected implicit, equation. Finally, experimental results of structural features vs.  $P_{an}$  and  $\Delta V$  are usually obtained in anodizing regimes with narrower  $P_{an}$  and  $\Delta V$  domains, mostly for the best hexagonal structure ordering, whereby satisfactory linear approximations may be possible.

The Eqs. (9)–(11) can be given in differential forms usable later

$$dD_{c}/dP_{an} = f_{c} + P_{an}(df_{c}/dP_{an}), \ dD_{n}/dP_{an} = f_{p} + P_{an}(df_{p}/dP_{an}), \ d(blt)/dP_{an} = f_{b} + P_{an}(df_{b}/dP_{an})$$
(12)

$$\frac{dD_c}{d(\Delta V)} = f_c + \Delta V [df_c / d(\Delta V)] + dg_c / d(\Delta V), \quad dD_p / d(\Delta V) = f_p + \Delta V [df_p / d(\Delta V)] + dg_p / d(\Delta V),$$

$$\frac{d(\Delta V)}{d(\Delta V)} = f_b + \Delta V [df_b / d(\Delta V)] + dg_b / d(\Delta V)$$

$$(13)$$

In a relatively narrow range of  $P_{an}$  considering that  $f_c$ ,  $f_p$  and  $f_b$  vary only slightly,  $df_c/dP_{an} \approx 0$ ,  $df_p/dP_{an} \approx 0$ ,  $df_b/dP_{an} \approx 0$ , and  $dD_c/dP_{an}$ ,  $dD_p/dP_{an}$ and  $d(blt)/dP_{an} \approx mean f_c$ ,  $f_p$  and  $f_b$  or  $\approx$  those at the middle of the range. Similarly, for slight changes in  $f_c$ ,  $f_p$ ,  $f_b$ ,  $g_c$ ,  $g_p$  and  $g_b$  within such narrow  $\Delta V$ range,  $df_c/d(\Delta V) \approx 0$ ,  $df_p/d(\Delta V) \approx 0$ ,  $df_b/d(\Delta V) \approx 0$ ,  $dg_c/d(\Delta V) \approx 0$ ,  $dg_p/d(\Delta V) \approx 0$ ,  $dg_b/d(\Delta V) \approx 0$ , and  $dD_c/d(\Delta V)$ ,  $dD_p/d(\Delta V)$  and  $d(blt)/d(\Delta V) \approx mean f_c$ ,  $f_p$  and  $f_b$  or  $\approx$  those at the middle of  $\Delta V$  range.

## **3.4.** Required conditions for experimental linear dependencies of $D_c$ , $D_p$ and *blt* on $P_{an}$ and $\Delta V$

The complete requirements for accurate linear  $D_c$ ,  $D_p$  and *blt* vs.  $P_{an}$  functions in an anodizing regime are: (a) as  $P_{an}$  rises, *n* falls; thus  $D_c$  rises; (b) the corresponding change of  $D_c$ ,  $D_p$  and *blt* is much higher than experimental error of their determination; (c<sub>1</sub>) constant  $f_c$ ,  $f_p$  and  $f_b$ , which means constant  $\alpha$  (or  $E_{bl}$  and  $\varphi$ ) and  $tn_{an}$ ; (d<sub>1</sub>) intercepts of plots  $\approx 0$ .

For simply satisfactory linear plots these become: (a); (b); (c<sub>2</sub>) almost constant or slightly varying  $f_c$ ,  $f_p$  and  $f_b$ ; thus the same is valid for  $\alpha$  (or  $E_{bl}$  and  $\varphi$ ) and  $tn_{an}$ ; (d<sub>2</sub>) the intercepts of plots may deviate somewhat from 0 but not significantly.

Accurate linear  $D_c$ ,  $D_p$  and *blt* vs.  $\Delta V$  plots require: (a) where  $\Delta V$  is considered instead of  $P_{an}$ ; (b); (c<sub>1</sub>); (d<sub>3</sub>) constant  $g_c$ ,  $g_p$  and  $g_b$  thus alike  $\alpha$  (or  $E_{bl}$  and  $\varphi$ ),  $tn_{an}$  and  $\Delta V_{bs} - P_{cath} = IR_{bs} + a + b \ln j_c$ , while  $-g_c$ ,  $-g_p$ and  $-g_b \ll$  experimental  $D_c$ ,  $D_p$  and *blt*, respectively.

For simply satisfactory linear plots vs.  $\Delta V$ , requirements are: (a) as above; (b); (c<sub>2</sub>); (d<sub>4</sub>) almost constant or slightly varying  $g_c$ ,  $g_p$  and  $g_b$  thus alike  $\alpha$  (or  $E_{bl}$  and  $\varphi$ ),  $tn_{an}$  and  $\Delta V_{bs}$  -  $P_{cath}$ , while - $g_c$ , - $g_p$  and - $g_b$  << experimental  $D_c$ ,  $D_p$  and *blt*.

Since strictly linear dependencies of structural features on  $P_{an}$  and  $\Delta V$  in the widest definition domains of  $P_{an}$  and  $\Delta V$  seem really impossible, the point is to evaluate the experimental dependencies in narrower ranges than these domains. If the requirements are satisfied, the linear functions are found from experimental results by regression analysis and their quality is estimated by common criteria. Some requirement(s) from (d<sub>2</sub>)–(d<sub>4</sub>) can be checked from the beginning, but (d<sub>1</sub>) cannot. Finally, regression analysis can *ex post* affirm or deny (d<sub>1</sub>)–(d<sub>4</sub>). Requirements (a), (b), (c<sub>1</sub>)–(c<sub>4</sub>), (d<sub>1</sub>), (d<sub>2</sub>) and the first legs of (d<sub>3</sub>) and (d<sub>4</sub>) are clear, but the second legs of (d<sub>3</sub>) and (d<sub>4</sub>) need further assistive proof to become legible.

Always  $E_{bl}$  is about 1 V nm<sup>-1</sup> [2–5]. Assuming mean  $\varphi \approx 131.5^{\circ}$ ,  $\alpha$  is about 0.75 nm V<sup>-1</sup>. In experiments at all *T*s and *j*s (section 3.2)  $\Delta V_{bs} - P_{cath} \leq 1.62$  V, Fig. 3, then  $\beta \leq 1.22$  nm. Also  $\Delta V_{bs} - P_{cath}$  is a small portion of  $P_{an}$ , 2.1–15.1%. The *blt*  $\approx$  (1 nm V<sup>-1</sup>)  $\times$ ( $P_{an}$ ), thus  $\beta << blt$ . For  $tn_{an}$  0.5–0.95 [49, 50] - $g_c$  and  $-g_p$  become at most  $\approx 8.33-3.15$  nm and  $\approx 5.89-$ 0.71 nm. Usually,  $D_c \geq$  many tens up to hundreds of nm and  $D_p \geq a$  few tens of nm up to many tens of nm [5, 6, 22-27], thus  $-g_c << D_c$  and  $-g_p << D_p$ .

These are valid also for the electrolytes H<sub>3</sub>PO<sub>4</sub>, H<sub>2</sub>C<sub>2</sub>O<sub>4</sub> etc. that are less conductive than H<sub>2</sub>SO<sub>4</sub>. At identical *c*, *T* and *j*,  $\Delta V_{\text{bs}}$  -  $P_{\text{cath}}$  is higher, but  $P_{\text{an}}$ ,  $\Delta V$ , *blt*,  $D_c$  and  $D_p$  are also higher [6, 22, 26, 27] and the second legs of (d<sub>3</sub>) and (d<sub>4</sub>) are satisfied too.

 $D_{\rm p}$  generally varies slightly (as compared to  $D_{\rm c}$ ) with  $P_{\rm an}$  and  $\Delta V$  [5, 6, 22-25, 27], sometimes it is almost constant, while as previously noted a slight decrease cannot be excluded. These are due to the fact that  $f_{\rm p} < f_{\rm c}$ . For  $tn_{\rm an} = 0.5-0.95$  [49, 50]  $f_{\rm c}$  and  $f_{\rm p}$  are found to be 6.83sin $\varphi E_{\rm bl}^{-1}$ -2.58sin $\varphi E_{\rm bl}^{-1}$  and 4.83sin $\varphi E_{bl}^{-1}$ -0.58sin $\varphi E_{bl}^{-1}$  while  $f_b = E_{bl}^{-1}$ .  $E_{bl}$  is always about 1 V nm<sup>-1</sup> thus  $f_c$  and  $f_p$  depend mostly on  $m_{an}$  and  $f_b$  depends solely on  $E_{bl}$ . Then,  $f_c$  and  $f_p$ decrease with  $m_{an}$ . The ratio  $f_c/f_p$  is independent of  $E_{bl}$  and  $\varphi$ . It varies as (6.83/4.83)–(2.58/0.58) thus 1.41–4.47, justifying the larger variation of  $D_c$  than  $D_p$ . Especially at high  $m_{an}$ s this ratio value becomes significant. The  $f_c/f_b$  varies as 6.83sin $\varphi$ -2.58sin $\varphi$ and  $f_p/f_b$  as 4.83sin $\varphi$ -0.58sin $\varphi$ . The  $g_c$  and  $g_p$  vary as [-6.83sin $\varphi E_{bl}^{-1}(\Delta V_{bs} - P_{cath})]$ -[-2.58sin $\varphi E_{bl}^{-1}(\Delta V_{bs} - P_{cath})]$  and [-4.83sin $\varphi E_{bl}^{-1}(\Delta V_{bs} - P_{cath})]$ -[-0.58 sin $\varphi E_{bl}^{-1}(\Delta V_{bs} - P_{cath})]$  while  $g_b = -E_{bl}^{-1}(\Delta V_{bs} - P_{cath})$ . The algebraic values of  $g_c$  and  $g_p$  increase with  $m_{an}$ . The ratios of  $g_c$ ,  $g_p$  and  $g_b$  vary as the corresponding ones of  $f_c$ ,  $f_p$  and  $f_b$ .

## **3.5.** Testing of the validity of formulated $D_c$ , $D_p$ and *blt* vs. $P_{an}$ and $\Delta V$ equations. Explanation of experimental results

The validity of the formulated equations is first examined in terms of experimental literature  $D_{\rm c}$ ,  $D_{\rm p}$  and *blt* vs.  $\Delta V$  plots. Gradients are always > 0 for  $D_c$  and *blt*, as predicted. Gradient for  $D_p$  is usually  $\geq 0$ ; non-exclusion of gradient < 0 means that, while  $D_p$  obeys Eq. (10),  $f_p$  (> 0) concurrently depends on and falls significantly with  $\Delta V$ . As shown earlier within relatively narrow  $P_{an}$  and  $\Delta V$ ranges  $f_c$ ,  $f_p$ , and  $f_b$  are almost constant, thus this is valid for  $f_c/f_p$ ,  $f_c/f_b$  and  $f_p/f_b$ . If the accurate  $\alpha$  (or  $E_{bl}$ and  $\varphi$ ) values are unknown, then the  $f_c/f_p$ ,  $f_c/f_b$  and  $f_{\rm p}/f_{\rm b}$  and therefore the ratios of plots' gradients can be used for comparisons. Even if  $\alpha$  varies with  $\Delta V$ , but not largely, its mean value can be considered in the employed  $\Delta V$  range. Then these ratios serve for comparisons too. In [22], the ratio of gradients in  $D_{\rm c}$ and  $D_p$  vs.  $\Delta V$  plots is  $\approx 2.77/1.29 \approx 2.15$ . In [24] it is  $\approx 3.2/1.3 \approx 2.46$ . In [25] it is  $\approx 1.05 \times 1.84/0.8 \approx$ 2.42,  $\approx 1.05 \times 2.1/0.53 \approx 4.16$  and  $\approx 1.05 \times 1.87/0.72$  $\approx$  2.73 at the employed Ts. All ratios fall in the 1.41–4.47 range. For  $\varphi \approx 131.5^{\circ}$  and  $tn_{an} = 0.5-0.95$ ,  $f_{\rm c}/f_{\rm b} \approx 5.12$ –1.94, including the ratio of related plots' gradients in [27] that is  $1.05 \times 2.4/1.1 = 2.3$ .

In [5] the  $D_c$  and  $P_{an}$  that vary with *t* in steady state give  $D_c$  vs.  $P_{an}$  plots at different constant *T*s with (correctly) positive gradient. Gradient rises with *T*, mainly due to drop of  $tn_{an}$  with *T*, as Eq. (9) predicts.

The picture for intercepts differs very much. In [22] the intercepts are  $\approx 0$ , in [23] reported values are > 0, in [24, 25] these are respectively < 0 and > 0

despite nearby anodizing conditions, in [26, 27] these are < 0 and in [5] these are > 0 for plots obtained at various *T*s and < 0 for plots obtained at various *t*s and for each employed *T*. But in Eqs. (9)–(11)  $g_c$ ,  $g_p$  and  $g_b < 0$ . Results are also explainable. The  $f_c$ ,  $f_p$ ,  $f_b$ ,  $g_c$ ,  $g_p$  and  $g_b$  depend on a large number of kinetic parameters that may change in complex ways within an anodizing regime. Then, this is valid for  $f_c$ ,  $f_p$ ,  $f_b$ ,  $g_c$ ,  $g_p$  and  $g_b$  too. For ease, as examples, some cases from Table 1, with a limited number of variable kinetic parameters and with available experimental results, are discussed.

Experimental linear plots refer to  $P_{an}$  or  $\Delta V$  ranges shorter than the widest definition domains. If in these domains results were available, e.g. for the cases (iv), (viii) and (xii) where  $P_{an}$ ,  $\Delta V$  and j together rise, real plots should bend to the right, Fig. 4 curve I. Along I the gradient of tangent falls with  $P_{\rm an}$  or  $\Delta V$ , while the intercept increases from < 0to > 0 value. In a narrower  $P_{an}$  or  $\Delta V$  range, the gradient and intercept of experimental linear plots of structural features vs.  $P_{an}$  or  $\Delta V$  are approached by those of tangent at a point around the middle of this range and follow those of the tangent as the range shifts. Indeed, as shown earlier, in such a range of  $P_{\rm an} dD_{\rm c}/dP_{\rm an}$  or  $dD_{\rm p}/dP_{\rm an}$  or  $d(blt)/dP_{\rm an} \approx$  $f_{\rm c}$  or  $f_{\rm p}$  or  $f_{\rm b}$  at the middle of  $P_{\rm an}$  range. Similarly,  $dD_c/d(\Delta V)$  or  $dD_p/d(\Delta V)$  or  $d(blt)/d(\Delta V) \approx f_c$  or  $f_p$ or  $f_b$  at the middle of  $\Delta V$  range. Thus the tangent gradient  $\approx$  this  $f_c$  or  $f_p$  or  $f_b$ . In both cases tangent intercept generally varies. For such ranges that shift to the right, it can be transformed from < 0 to > 0.

Such bending of large range plots, is mainly due to changes of j and  $tn_{an}$  with  $E_{bl}$  and  $T_{an}$ , Eqs. (1) and (2). As  $P_{an}$ ,  $\Delta V$  and j rise,  $E_{bl}$  and  $tn_{an}$  rise and  $f_c$ ,  $f_p$  and  $f_b$  fall.  $T_{an}$  depends on the rates of heat production, mainly around the barrier layer, and its abduction to the solution. Thus it depends on j,  $P_{an}$ or  $\Delta V$  and overall heat transport coefficient which in turn depends on film thickness, porosity, stirring rate etc. [32]. For high stirring rate and not very high js,  $P_{an}$ s or  $\Delta V$ s and thickness,  $T_{an}$  rises slightly with  $P_{an}$  or  $\Delta V$  reducing  $tn_{an}$ . But the effect of  $E_{bl}$ dominates. In other cases the effect of  $T_{an}$  may dominate.

In [5] at constant *c*, *T* and *j* and various *t*s, case (i),  $P_{an}$ ,  $\Delta V$  and structural features change with *t*. The intercept of approximate linear  $D_c$  vs.  $P_{an}$  plot was < 0. In analogy to the above, at each *T* the  $D_c$  vs.



Widest definition domain of  $P_{an}$  or  $\Delta V / V$ 

**Fig. 4.** Schematic curved dependencies of PAAF structural features on anodic potential,  $P_{an}$ , or anodizing voltage,  $\Delta V$ , in their widest possible definition domain. The curves explain qualitatively the general multimodal dependence of structural features on the potential in three example cases. The broken lines represent the tangent line at various points. As the point of contact of the tangent to the curve shifts, both the gradient and intercept of the tangent change. The gradient and intercept of experimental linear plots, at a relatively narrow range around the point, change similarly. The multimodal dependence of the structural features on  $P_{an}$  and  $\Delta V$  comes from concurrent change of the factors  $f_c$ ,  $f_p$  and  $f_b$  and of the terms  $g_c$ ,  $g_p$  and  $g_b$  in the implicit pseudo-linear Eqs. (9)–(11), with  $P_{an}$  and  $\Delta V$ .

 $P_{an}$  plot in the widest definition domain must bend left, curve II, due mostly to  $T_{an}$  rise. As the thickness of film increases, the abduction of heat is hindered more, while the heat is released at a higher rate as  $P_{an}$  concurrently rises [32]. The gradient of tangent rises and intercept falls with  $P_{an}$  or  $\Delta V$ , followed by those of experimental plots in a range shorter than the definition domain as the range shifts. In the employed  $P_{an}$  ranges, the intercept is < 0. Its fall with T is due to the simultaneous shift and turn to the left of curve II, so that generally the gradient increases and intercept decreases. This also holds for the employed  $P_{an}$  ranges [5].

Each of  $f_c$ ,  $f_p$  and  $f_b$  is affected by kinetic parameters to different extents. Each of  $g_c$ ,  $g_p$  and  $g_b$  alike is affected by more kinetic parameters. The profile of each structural feature vs.  $P_{an}$  or  $\Delta V$  plot may thus

differ from the other ones, mainly in large  $P_{\rm an}$  or  $\Delta V$  ranges. In [23] (case (iv) at various Ts and cs) the  $D_c$  vs.  $\Delta V$  plot is approximately linear but the  $D_{\rm p}$  and *blt* vs.  $\Delta V$  plots bend left and right, respectively. For  $D_{\rm p}$ , plot bending, occurring mainly in the region of high  $\Delta Vs$  and *js*, is due to significant rise of  $T_{an}$ , the effect of which on  $tn_{an}$  now dominates. For *blt*, plot bending is due to the increase of  $E_{\rm bl}$ (or due to the decrease of  $f_{\rm b} = E_{\rm bl}^{-1}$ ) with  $\Delta V$  and j. In anodizing regimes with more variable anodizing parameters, the  $f_c$ ,  $f_p$ ,  $f_b$ ,  $g_c$ ,  $g_p$  and  $g_b$  must be affected by more variable kinetic parameters. In the widest definition domains, real plots may be more complex, such as curve III, etc.  $D_p$  may even fall monotonically or change in another way. In these cases the explanations become more complex.

As shown in section 3.3 the exception from monotonic or linear increase of  $D_c$ ,  $D_p$  and *blt* with  $P_{an}$  or  $\Delta V$  at constant  $P_{an}$ , c and T and variable t (case (v)), Fig. 1, is also compatible with Eqs. (9)-(11). In DG region the rates of incessant pore termination/generation processes are least and balanced, as shown by the micrograph at the middle of film cross section at H. It shows porous structure just above metal|oxide interface when the film had thickness  $\approx$  23 µm (half that at H). The 23 µm thickness is formed at t within DG. Termination or generation of pores is not detected. In DG region the structural features are expected to be embodied in linear or other monotonic plots of  $D_c$  and *blt* (and presumably of  $D_p$ ) vs.  $P_{an}$  or  $\Delta V$  for various  $P_{an}$ s, case (viii). But, from G to H pore generation dominates and after H termination does. At H, Fig. 1c–d, maxima of  $tn_{an}$  and n and minima of  $D_{c}$ ,  $D_{\rm p}$  and *blt* appear. While  $P_{\rm an}$  is constant and  $\Delta V$ rises, n increases. Thus, the requirement (a) is not satisfied, justifying the exception. This change of *n* at prolonged anodizing is explained as follows.

Beyond G the significant increase in film thickness favours appreciable  $T_{an}$  rise and accumulation of Al<sup>3+</sup> and electrolyte anions around pore bases [52, 53], which must be among the main factors favouring pore branching inwards and *n* rise. Thickening beyond H causes further  $T_{an}$  rise and significant mass transfer retardation due to lengthy pores some of which become labyrinthine by termination/ generation processes. Excessive accumulation of such species produces colloidal nanoparticles [54] (made of  $Al^{3+}$ , electrolyte anions,  $H_2O$  and  $OH^{-}$ ) and complex cations  $Al(OH)^{2+}$ ,  $Al_2(OH)_2^{+}$ ,  $Al_2(OH)_2^{4+}$ ,  $Al_3(OH)_6^{3+}$ ,  $Al[(OH)_5Al_2]_n^{(n+3)+}$ ,  $Al_6(OH)_{15}^{3+}$  etc. [55, 56], that are less mobile than  $H^+$  [33]. Their intense presence at pore bases seems to hinder generation of new pores and favor termination. Structure changes are expected until attainment of maximum limiting mean film thickness, pore length, porosity and species concentrations at pore bases, beyond J as plots in Fig. 1 predict. Solution composition at pore bases affects these processes, just as the electrolyte type defines the growth of porous or nonporous films or pitting [51].

Nucleation of pores [57] occurs around C, Fig. 1. Then termination of pores dominates over generation up to about D [31]. Constant  $D_c$ ,  $D_p$  and *blt* at constant  $P_{an}$  or  $\Delta V$  are possible when the rates of pore generation/termination are balanced or  $\approx 0$ . This occurs in DG region, supporting the rule that structural features in the first range of steady state must be taken into consideration in order to reveal their real dependencies on  $P_{an}$  or  $\Delta V$ . The *t* must lie in this range but it may not be constant as *t*(D) varies e.g. with *c*, *T*, *j*,  $P_{an}$  and  $\Delta V$ . The results in all other cases of Table 1 or in other even more complex cases are explained by analyses similar to the above.

#### 4. CONCLUSIONS

From this investigation the main concluding remarks are the following:

- 1. In steady state of PAAF growth, the structural features obey implicit pseudo-linear equations  $D_c = f_c P_{an} = f_c \Delta V + g_c$ ,  $D_p = f_p P_{an} = f_p \Delta V + g_p$  and  $blt = f_b P_{an} = f_b \Delta V + g_b$ . The  $f_b$  (> 0) depends on field strength and angle between pore axis and barrier layer/pore wall boundary,  $f_c$  and  $f_p$  (> 0) depend also on  $O^{2-}$  transport number in barrier layer and the  $g_c$ ,  $g_p$  and  $g_b$  (< 0) moreover on current, solution resistance, current density in cathode and H<sub>2</sub> release Tafel parameters. Some parameters defining  $f_c$ ,  $f_p$ ,  $f_b$ ,  $g_c$ ,  $g_p$  and  $g_b$  depend in turn on  $P_{an}$  and  $\Delta V$  and other interdepend. So,  $f_c$ ,  $f_p$ ,  $f_b$ ,  $g_c$ ,  $g_p$  and  $g_b$  change with  $P_{an}$  or  $\Delta V$  by various modes. Linear or other one-type monotonic increase of  $D_c$  or  $D_{int}$ , *blt* and  $D_p$  with  $P_{an}$  or  $\Delta V$  is not assured.
- 2. The monotonic or linear increase of  $D_c$  or  $D_{int}$ ,  $D_p$  and *blt* with  $P_{an}$  or  $\Delta V$ , when existing, cannot be artificially created by  $\Delta V_{bs}$   $P_{cath}$  included in  $\Delta V$ .  $\Delta V_{bs}$   $P_{cath}$  is embodied in  $g_c$ ,  $g_p$  and  $g_b$ .

- 3. Requirements for linear plots of structural features vs.  $P_{an}$  or  $\Delta V$ , obeying the above equations, were formulated. In the widest  $P_{an}$  (or  $\Delta V$ ) definition domains, maintaining the characteristic PAAF structure, exact linear plots, thus constant  $f_c$ ,  $f_p$  and  $f_b$  with  $g_c$ ,  $g_p$  and  $g_b \approx 0$  (or constant  $f_c$ ,  $f_p$ ,  $f_b$ ,  $g_c$ ,  $g_p$  and  $g_b$ ), seem rather impossible. Almost constant or slightly changing kinetic parameters may yield tolerable linear plots in ranges of  $P_{an}$  or  $\Delta V$  narrower than these domains.
- 4. For anodizing regimes which do not assure constant  $f_c$ ,  $f_p$ ,  $f_b$ ,  $g_c$ ,  $g_p$  and  $g_b$  in the widest  $P_{an}$ (or  $\Delta V$ ) domains, each  $D_c$ ,  $D_p$  and *blt* vs.  $P_{an}$ or  $\Delta V$  plot deviates from linear in various ways and the dependence of  $D_c$ ,  $D_p$  and *blt* on  $P_{an}$  or  $\Delta V$  is in fact multimodal.
- 5. Tolerable experimental linear structural features vs.  $P_{an}$  or  $\Delta V$  plots, often associated with hexagonal maximum pore ordering, actually refer to ranges of  $P_{an}$  and  $\Delta V$  narrower that definition domains. Even for the same electrolyte and neighboring anodizing conditions, gradients and intercepts of plots can thus vary and intercept can be either  $\leq 0$  or > 0.
- 6. Monotonic increase of D<sub>c</sub> with P<sub>an</sub> and ΔV means decrease of *n* with them. Exceptions are observed e.g. during prolonged Al anodizing at constant P<sub>an</sub> where *n* varies similarly to *j* and ΔV while D<sub>c</sub>, D<sub>p</sub> and blt vary inversely. These are due to unstable *n*, coming from continuous pore termination/generation processes as a result of altered conditions at pore bases.
- 7. The experimental linear or other monotonic dependencies of  $D_c$ ,  $D_p$  and *blt* vs.  $P_{an}$  or  $\Delta V$  and exceptions were adequately explained for the first time. A novel theoretical tool was presented, revealing the real dependence of PAAF structure on anodizing potential, important for the Al anodizing electrochemistry and numerous PAAF applications.

#### **CONFLICT OF INTEREST STATEMENT**

The author declares no conflict of interest.

#### ABBREVIATIONS

 $a_2$  and  $a_3 =$  Activation (half jump) distances of O<sup>2-</sup> and Al<sup>3+</sup> transport inside the barrier layer (nm).

a and b	=	Tafel parameters for hydrogen evolution on	п	=	Surface density of oxide cell/pore units near the
		cathodes.			Al substrate surface ( $\text{cm}^{-2}$ ).
$\alpha$ (Greek)	=	$E_{\rm bl}^{-1}$ .	$n_2$ and $n_3$	=	Valences of $O^{2-}$ and $Al^{3+}$
$\beta$ (Greek)	=	$(IR_{\rm hs} + a + b \ln j_c)E_{\rm hl}^{-1}$ .			ions.
$A_2$ and $A_3$	=	Pre-exponential factors	PAAF	=	Porous anodic alumina
2 5		in Eqs. $(1)$ and $(2)$ (mA			film.
		$cm^{-2}$ ).	$P_{\rm an}$	=	Anodic potential vs.
blt	=	Barrier layer thickness	un		SHE (V).
		(nm)	$P_{\rm cath}$	=	Cathodic potential vs.
C	=	Concentration of H <sub>2</sub> SO <sub>4</sub>			SHE (V).
c	_	or other anodizing	$P_{\rm an} - P_{\rm ref}(a)$	=	Potential difference
		electrolyte (M)			between Al anode and
D D and D	_	mean cell width			reference electrode
$D_{\rm c}, D_{\rm int}$ and $D_{\rm p}$	_	internore distance and			close to anode (V).
		nerpore distance and	$P_{\rm cath} - P_{\rm ref}(a)$	=	Potential difference
4 D		pore base diameter (iiii).			between cathode and
$\Delta P$	=	Potential drop across the			reference electrode
A T 7		barrier layer (v).			close to anode (V).
$\Delta V$	=	anodizing voltage (V).	$P_{\text{outh}} - P_{\text{ref}}(c)$	=	Potential difference
$\Delta V_{\rm bs}$	=	Potential drop in bath			between cathode and
		solution between Al anode			reference electrode
_		and Pb cathodes (V).			close to cathode (V).
$E_{ m bl}$	=	Mean high field strength	R	=	Universal gas constant
		across the barrier layer	it i		$(8.314 \text{ J K}^{-1} \text{ mol}^{-1})$
		$(V nm^{-1}).$	$R_{\rm bac}$	=	Resistance of bath bulk
$f_{c}$	=	$\sin \varphi E_{bl}^{-1} 2[1 - (1 - 1)]$	1108		solution during Al
		$tn_{\rm an})^{1/2}$ ] <sup>-1</sup> , (>0), (nm V <sup>-1</sup> ).			anodizing (Ohm)
$f_{p}$	=	$\sin \varphi E_{bl}^{-1} 2[1 - (1 - 1)]$	S	=	Total conductive
		$(tn_{\rm an})^{1/2}]^{-1}(1 - tn_{\rm an})^{1/2},$	~(		geometric surface area
		$(>0), (nm V^{-1}).$			of two Pb cathodes where
$f_{ m b}$	=	$E_{\rm bl}^{-1}$ , (> 0), (nm V <sup>-1</sup> ).			$H_2$ is released (cm <sup>2</sup> )
$\varphi$	=	angle between pore axis	S-	=	Geometric surface area
		and barrier layer/pore	Sg		of Al specimens that is
		wall boundary.			oxidized during
F	=	Faraday's constant			anodizing (cm <sup>2</sup> )
		$(96487 \text{ C mol}^{-1}).$	t	=	anodizing time (min or s)
FESEM	=	Field Emission	tn and tn	_	Transport numbers of
		Scanning Electron	man and mea	_	$\Omega^{2-}$ and $A1^{3+}$ across the
		Microscopy.			harrier laver
$g_{c}$	=	$-\beta 2[1 - (1 - tn_{an})^{1/2}]^{-1}$			(dimensionless)
80		(< 0), (nm),	Т	_	Temperature of bath
<i>Q</i>	=	$-\beta 2[1 - (1 - tn_{er})^{1/2}]^{-1}$	1	—	bulk solution (°C or K)
op		$(1 - tn_{\rm er})^{1/2}$ (< 0) (nm)	Т	_	Paal anodizing
$\sigma_{\rm h}$	=	$-(\sin \alpha)^{-1}\beta$ (< 0) (nm)	∎ an	—	temperature in the harrier
80 I	_	iS = iS = Current(A)			lower region (9C or V)
i	_	$\int_{S_g} - \int_{C_0} \int_{C_0} C_{urrent} density in A1$	$\mathbf{W}$ , and $\mathbf{W}$ ,	_	ayer region (°C or K).
J	_	anode $(m \Lambda cm^{-2})$	$w_2$ and $w_3$	=	Apparent activation energies of $\Omega^{2-}$ and $\Lambda^{13+}$
		anoue (mA cm ).			energies of U and Al

Current density in

cathodes (mA cm<sup>-2</sup>).

=

 $j_{c}$ 

Dependence of PAAF nanostructure on anodizing potential

transport across the

barrier layer (J mol<sup>-1</sup>).

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